

Search Notes

Application/Control No.

10/649,172

Examiner

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Applicant(s)/Patent under
Reexamination

SAIKA, NOBUYUKI

Art Unit

2163

SEARCHED

Class	Subclass	Date	Examiner
707	1-10, 100, 200-206	9/28/2006	MF
709	203, 213	9/28/2006	MF
710	1,5,38	9/28/2006	MF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
707	1, 10	9/28/2006	MF
707	200	9/28/2006	MF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST; IEEE; CiteSeer; file server, compar/match file/ids, mirror/replicate target/source, consult Coby (AU2161)	9/28/2006	MF
update search using previous concept	9/28/2006	MF